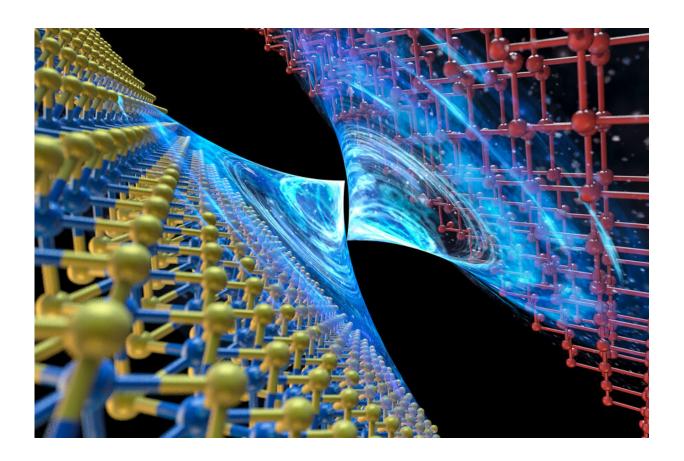


## Advance may enable 2D transistors for tinier microchip components

May 14 2021, by David L. Chandler



At the interface between the semimetal (bismuth) and the 2D semiconductor (MoS2), there is no energy barrier for the electron to go through, leading to an ultralow contact resistance between them. Credit: Massachusetts Institute of Technology

Moore's Law, the famous prediction that the number of transistors that



can be packed onto a microchip will double every couple of years, has been bumping into basic physical limits. These limits could bring decades of progress to a halt, unless new approaches are found.

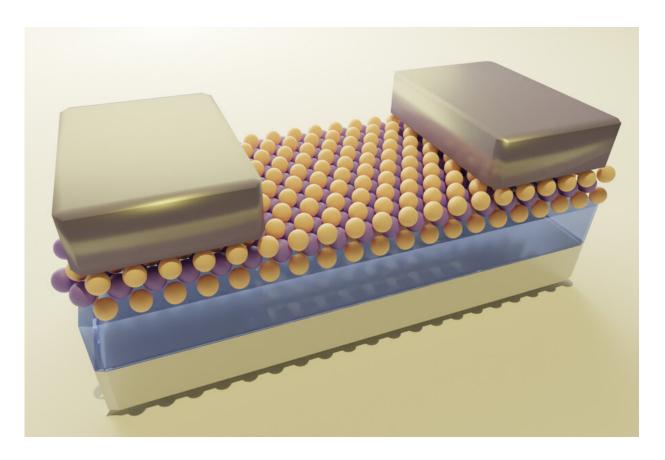
One new direction being explored is the use of atomically <u>thin materials</u> instead of silicon as the basis for new transistors, but connecting those "2D" materials to other conventional electronic components has proved difficult.

Now researchers at MIT, the University of California at Berkeley, the Taiwan Semiconductor Manufacturing Company, and elsewhere have found a new way of making those <u>electrical connections</u>, which could help to unleash the potential of 2D materials and further the miniaturization of components—possibly enough to extend Moore's Law, at least for the near future, the researchers say.

The findings are described this week in the journal Nature, in a paper by recent MIT graduates Pin-Chun Shen Ph.D. '20 and Cong Su Ph.D. '20, postdoc Yuxuan Lin Ph.D. '19, MIT professors Jing Kong, Tomas Palacios, and Ju Li, and 17 others at MIT, UC Berkeley, and other institutions.

"We resolved one of the biggest problems in miniaturizing semiconductor devices, the contact resistance between a metal electrode and a monolayer semiconductor material," says Su, who is now at UC Berkeley. The solution proved to be a simple one: the use of a semimetal, the element bismuth, to take the place of ordinary metals to connect with the monolayer material.





An illustration of the monolayer semiconductor transistor. Credit: Massachusetts Institute of Technology

Such ultrathin monolayer materials, in this case molybdenum disulfide, are seen as a major contender for a way around the miniaturization limits now being encountered by silicon-based transistor technology. But creating an efficient, highly conductive interface between such materials and <u>metal</u> conductors, in order to connect them to each other and to other devices and power sources, was a challenge holding back progress toward such solutions, Su says.

The interface between metals and semiconductor materials (including these monolayer semiconductors) produces a phenomenon called metalinduced gap state, which leads to the formation of a Schottky barrier, a

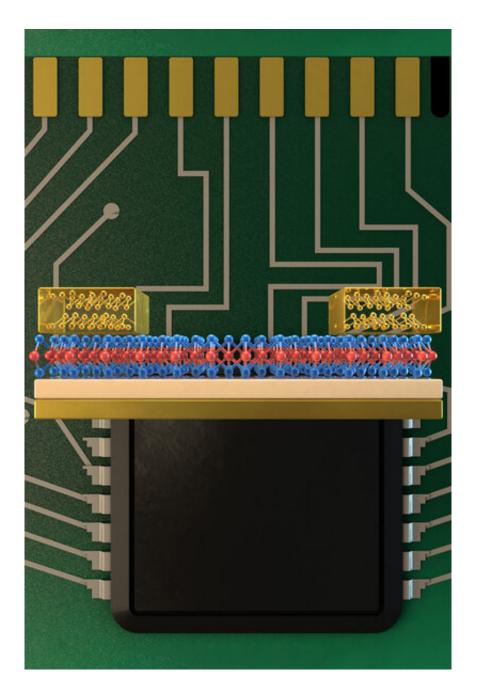


phenomenon that inhibits the flow of charge carriers. The use of a semimetal, whose electronic properties fall between those of metals and semiconductors, combined with proper energy alignment between the two materials, turned out to eliminate the problem.

Lin explains that the rapid pace of miniaturization of the transistors that make up computer processors and memory chips has stalled out before, around 2000, until a new development that allowed for a three-dimensional architecture of semiconductor devices on a chip broke the logjam in 2007 and rapid progress resumed. But now, he says, "we think we are on the edge of another bottleneck."

So-called two-dimensional materials, thin sheets just one or a few atoms thick, meet all the requirements for enabling a further leap in miniaturization of transistors, potentially reducing by several times a key parameter called the channel length—from around 5 to 10 nanometers, in current cutting-edge chips, to a subnanometer scale. A variety of such materials are being widely explored, including a whole family of compounds known as transition metal dichalcogenides. The molybdenum disulfide used in the new experiments belongs to this family.





With this technology, miniaturized transistors with extraordinary performances are demonstrated, meeting the requirements for the technological roadmap for future transistors and microchips. Credit: Massachusetts Institute of Technology

The issue of achieving a low-resistance metal contact with such materials has also been hampering basic research on the physics of these novel



monolayer materials. Because existing connection methods have such high resistance, the tiny signals needed to monitor the behavior of electrons in the material are too weak to get through. "There are numerous examples coming from the physics side that call for a low-contact resistance between the metal and a semiconductor. So, it's a huge problem in the physics world as well," Su says.

Figuring out how to scale up and integrate such systems at a commercial level could take some time and require further engineering. But for such physics applications, the researchers say, the impact of the new findings could be felt quickly. "I think in physics, many experiments can benefit from this technology immediately," Su says.

Meanwhile, the researchers continue to explore further, continuing to reduce the size of their devices and looking for other pairings of materials that might enable better electrical contacts to the other type of charge carriers, known as holes. They solved the problem for the so-called N-type transistor, but if they can find a combination of channel and electrical contact material to enable an efficient monolayer P-type transistor as well, that would open up many new possibilities for next-generation chips, they say.

**More information:** Pin-Chun Shen et al. Ultralow contact resistance between semimetal and monolayer semiconductors, *Nature* (2021). DOI: 10.1038/s41586-021-03472-9

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